Product Folder

Sample & Buy

Technical Documents

Tools & Software

Support & Community

TEXAS INSTRUMENTS

LMH6642Q-Q1, LMH6643Q-Q1

SNOSC61C –JANUARY 2012–REVISED SEPTEMBER 2014

LMH6642Q/LMH6643Q Low Power, 130 MHz, 75 mA Rail-to-Rail Output Amplifiers

1 Features

- (V_S = ±5 V, T_A = 25°C, R_L = 2 kΩ, A_V = +1. Typical Values Unless Specified).
- −3dB BW (A_V = +1) 130 MHz
- Supply Voltage Range 2.7 V to 10 V
- Slew Rate, (A_V = −1) 130V/µs[1]
- Supply Current (no load) 2.7 mA/amp
- Output Short Circuit Current +115 mA/−145 mA
- Linear Output Current ±75mA
- Input Common Mode Voltage 0.5V Beyond V⁻, 1V from V⁺
- Output Voltage Swing 40mV from Rails
- Input Voltage Noise (100kHz) 17nV/$\sqrt{Hz}$
- Input Current Noise (100kHz) 0.9pA/$\sqrt{Hz}$
- THD (5MHz, R_L = 2 kΩ, V_O = 2V_{PP}, A_V = +2) −62 dBc
- Settling Time 68ns
- Fully Characterized for 3 V, 5 V, and ±5 V
- Overdrive Recovery 100ns
- Output Short Circuit Protected[2]
- No Output Phase Reversal with CMVR Exceeded
- LMH6643QMM and LMH6642QMF are AEC-Q100 Grade 3 Qualified and are Manufactured on an Automotive Grade Flow

[1] Slew rate is the average of the rising and falling slew rates

[2] Output short circuit duration is infinite for V_S < 6 V at room temperature and below. For V_S > 6 V, allowable short circuit duration is 1.5 ms.

2 Applications

- Active Filters
- CD/DVD ROM
- ADC Buffer Amp
- Portable Video
- Current Sense Buffer
- Automotive

3 Description

The LMH664X family true single supply voltage feedback amplifiers offer high speed (130 MHz), low distortion (−62 dBc), and exceptionally high output current (approximately 75 mA) at low cost and with reduced power consumption when compared against existing devices with similar performance.
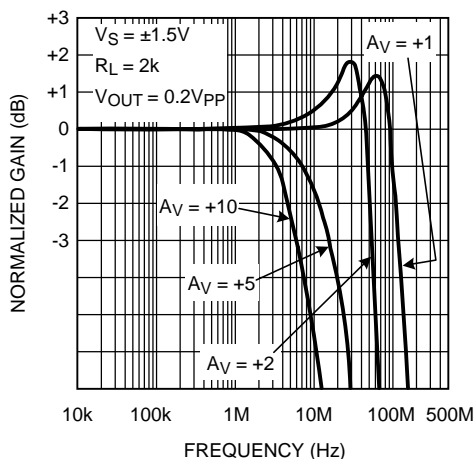
Input common mode voltage range extends to 0.5 V below V⁻ and 1 V from V⁺. Output voltage range extends to within 40mV of either supply rail, allowing wide dynamic range especially desirable in low voltage applications. The output stage is capable of approximately 75 mA in order to drive heavy loads. Fast output Slew Rate (130 V/µs) ensures large peak-to-peak output swings can be maintained even at higher speeds, resulting in exceptional full power bandwidth of 40 MHz with a 3-V supply. These characteristics, along with low cost, are ideal features for a multitude of industrial and commercial applications.

Device Information[1]

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMH6642-Q1	SOT-23 (5)	2.90 mm × 1.60 mm
LMH6643-Q1	VSSOP (8)	3.00 mm × 3.00 mm

[1] For all available packages, see the orderable addendum at the end of the datasheet.

Closed Loop Gain vs. Frequency for Various Gain
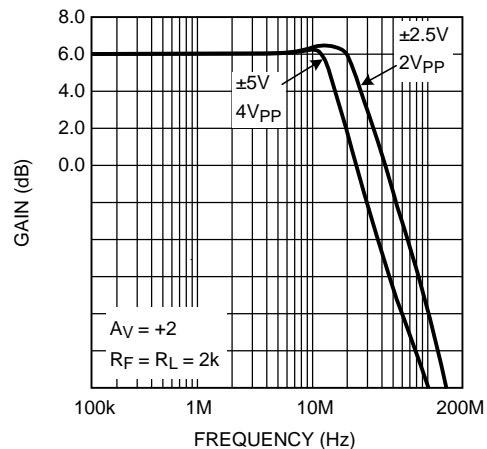

Large Signal Frequency Response

Table of Contents

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| **Changes from Revision B (March 2013) to Revision C**	**Page**
• Changed data sheet structure and organization. Added, updated, or renamed the following sections: Device Information Table, Pin Configuration and Functions, Application and Implementation; Device and Documentation Support; Mechanical, Packaging, and Ordering Information	1
• Changed "Junction Temperature Range" to "Operating Temperature Range" in Recommended Operating Conditions	4
• Deleted T_J = 25°C in Electrical Characteristics tables	5
• Deleted T_J = 25°C in Typical Performance Characteristics section.	11

Changes from Revision A (March 2013) to Revision B	**Page**
• Changed layout of National Data Sheet to TI format	24

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

5 Description (continued)

Careful attention has been paid to ensure device stability under all operating voltages and modes. The result is a very well behaved frequency response characteristic (0.1dB gain flatness up the 12MHz under 150Ω load and A_V = +2) with minimal peaking (typically 2dB maximum) for any gain setting and under both heavy and light loads. This along with fast settling time (68ns) and low distortion allows the device to operate well in ADC buffer, and high frequency filter applications as well as other applications.

This device family offers professional quality video performance with low DG (0.01%) and DP (0.01°) characteristics. Differential Gain and Differential Phase characteristics are also well maintained under heavy loads (150Ω) and throughout the output voltage range. The LMH664X family is offered in single (LMH6642) and dual (LMH6643).

6 Pin Configuration and Functions

5-Pin SOT-23 Package
Package DBV0005A
Top View

8-Pin VSSOP Package
Package DGK0008A
Top View
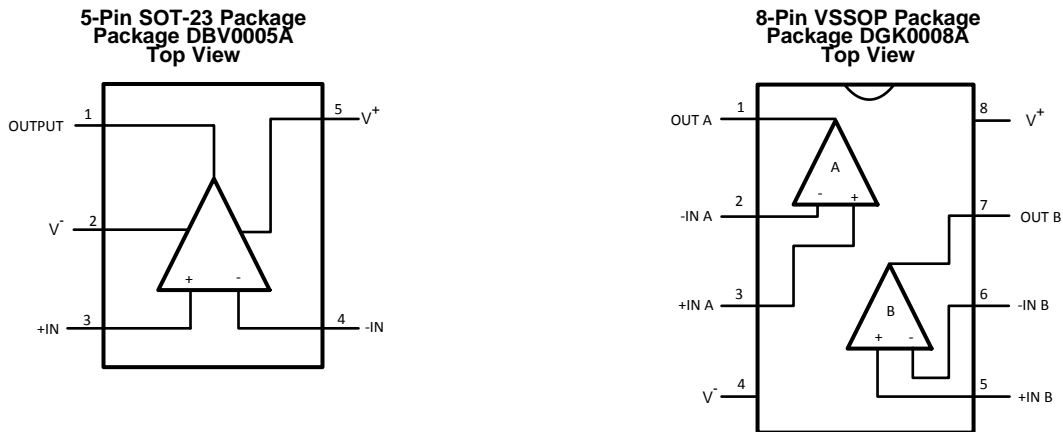
Pin Functions

PIN			I/O	DESCRIPTION
NAME	NUMBER			
	LMH6642Q	LMH6643Q		
-IN	4		I	Inverting Input
+IN	3		I	Non-inverting Input
-IN A		2	I	ChA Inverting Input
+IN A		3	I	ChA Non-inverting Input
-IN B		6	I	ChB Inverting Input
+IN B		5	I	ChB Non-inverting Input
OUT A		1	O	ChA Output
OUT B		7	O	ChB Output
OUTPUT	1		O	Output
V⁻	2	4	I	Negative Supply
V⁺	5	8	I	Positive Supply

7 Specifications

7.1 Absolute Maximum Ratings[(1)(2)(1)]

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
V_{IN} Differential		±2.5	V
Output Short Circuit Duration		See [(3)] and [(4)]	
Supply Voltage (V^+ - V^-)		13.5	V
Voltage at Input/Output pins		V^+ +0.8 V^- −0.8	V
Input Current		±10	mA
Junction Temperature [(5)]		+150	°C
Soldering Information			
Infrared or Convection Reflow (20 sec)		235	°C
Wave Soldering Lead Temp.(10 sec)		260	°C

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications and the test conditions, see the Electrical Characteristics.
(2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
(3) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C.
(4) Output short circuit duration is infinite for V_S < 6 V at room temperature and below. For V_S > 6 V, allowable short circuit duration is 1.5ms.
(5) The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$, and T_A. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly onto a PC board.

7.2 Handling Ratings

			MIN	MAX	UNIT
T_{stg}	Storage temperature range		−65	+150	°C
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002[(1)]		2000	V
		Machine Model (MM)[(2)]		200	
		Charged Device Model (CDM), per AEC Q100-011		1000	

(1) AEC Q100-002 indicates HBM stressing is done in accordance with the ANSI/ESDA/JEDEC JS-001 specification,1.5kΩ in series with 100pF.
(2) Machine Model, 0Ω in series with 200pF.

7.3 Recommended Operating Conditions[(1)]

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
Supply Voltage ($V^+ – V^-$)	2.7	10	V
Operating Temperature Range[(2)]	−40	+85	°C

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications and the test conditions, see the Electrical Characteristics.
(2) The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$, and T_A. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly onto a PC board.

7.4 Thermal Information

THERMAL METRIC[(1)]		DBV05A	DGK08A	UNIT
		5 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance[(2)]	265°C/W	235°C/W	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
(2) The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$, and T_A. The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly onto a PC board.

7.5 3V Electrical Characteristics

Unless otherwise specified, all limits ensured for V^+ = 3V, V^- = 0V, V_{CM} = V_O = V^+/2, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to V^+/2. **Boldface** limits apply at the temperature extremes.

	PARAMETER	TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
BW	−3dB BW	A_V = +1, V_{OUT} = 200mV_{PP}	80	115		MHz
		A_V = +2, −1, V_{OUT} = 200mV_{PP}		46		
$BW_{0.1dB}$	0.1dB Gain Flatness	A_V = +2, R_L = 150Ω to V+/2, R_L = 402Ω, V_{OUT} = 200mV_{PP}		19		MHz
PBW	Full Power Bandwidth	A_V = +1, −1dB, V_{OUT} = 1V_{PP}		40		MHz
e_n	Input-Referred Voltage Noise	f = 100kHz		17		nV/√Hz
		f = 1kHz		48		
i_n	Input-Referred Current Noise	f = 100kHz		0.90		pA/√Hz
		f = 1kHz		3.3		
THD	Total Harmonic Distortion	f = 5MHz, V_O = 2V_{PP}, A_V = −1, R_L = 100Ω to V^+/2		−48		dBc
DG	Differential Gain	V_{CM} = 1V, NTSC, A_V = +2 R_L =150Ω to V^+/2		0.17%		
		R_L =1kΩ to V^+/2		0.03%		
DP	Differential Phase	V_{CM} = 1V, NTSC, A_V = +2 R_L =150Ω to V^+/2		0.05		deg
		R_L =1kΩ to V^+/2		0.03		
CT Rej.	Cross-Talk Rejection	f = 5MHz, Receiver: R_f = R_g = 510Ω, A_V = +2		47		dB
T_S	Settling Time	V_O = 2V_{PP}, ±0.1%, 8pF Load, V_S = 5V		68		ns
SR	Slew Rate[3]	A_V = −1, V_I = 2V_{PP}	90	120		V/µs
V_{OS}	Input Offset Voltage	For LMH6642		±1	±5 **±7**	mV
		For LMH6643		±1	±3.4 **±7**	
TC V_{OS}	Input Offset Average Drift	[4]		±5		µV/°C
I_B	Input Bias Current	[5]		−1.50	−2.60 **−3.25**	µA
I_{OS}	Input Offset Current			20	800 **1000**	nA
R_{IN}	Common Mode Input Resistance			3		MΩ
C_{IN}	Common Mode Input Capacitance			2		pF
CMVR	Input Common-Mode Voltage Range	CMRR ≥ 50dB		−0.5	−0.2 **−0.1**	V
			1.8 **1.6**	2.0		
CMRR	Common Mode Rejection Ratio	V_{CM} Stepped from 0V to 1.5V	72	95		dB
A_{VOL}	Large Signal Voltage Gain	V_O = 0.5V to 2.5V R_L = 2kΩ to V^+/2	80 **75**	96		dB
		V_O = 0.5V to 2.5V R_L = 150Ω to V^+/2	74 **70**	82		
V_O	Output Swing High	R_L = 2kΩ to V^+/2, V_{ID} = 200mV	2.90	2.98		V
		R_L = 150Ω to V^+/2, V_{ID} = 200mV	2.80	2.93		
	Output Swing Low	R_L = 2kΩ to V^+/2, V_{ID} = −200mV		25	75	mV
		R_L = 150Ω to V^+/2, V_{ID} = −200mV		75	150	

(1) All limits are ensured by testing or statistical analysis.
(2) Typical values represent the most likely parametric norm.
(3) Slew rate is the average of the rising and falling slew rates.
(4) Offset voltage average drift determined by dividing the change in V_{OS} at temperature extremes by the total temperature change.
(5) Positive current corresponds to current flowing into the device.

3V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for V^+ = 3V, V^- = 0V, V_{CM} = V_O = V^+/2, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to V^+/2. **Boldface** limits apply at the temperature extremes.

PARAMETER		TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
I_{SC}	Output Short Circuit Current	Sourcing to V^+/2 V_{ID} = 200mV [6]	50 **35**	95		mA
		Sinking to V^+/2 V_{ID} = −200mV [6]	55 **40**	110		
I_{OUT}	Output Current	V_{OUT} = 0.5V from either supply		±65		mA
+PSRR	Positive Power Supply Rejection Ratio	V^+ = 3.0V to 3.5V, V_{CM} = 1.5V	75	85		dB
I_S	Supply Current (per channel)	No Load		2.70	4.00 **4.50**	mA

(6) Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5ms.

7.6 5V Electrical Characteristics

Unless otherwise specified, all limits ensured for V^+ = 5V, V^- = 0V, V_{CM} = V_O = $V^+/2$, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to $V^+/2$. **Boldface** limits apply at the temperature extremes.

PARAMETER		TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
BW	−3dB BW	A_V = +1, V_{OUT} = 200mV_{PP}	90	120		MHz
		A_V = +2, −1, V_{OUT} = 200mV_{PP}		46		
BW$_{0.1dB}$	0.1dB Gain Flatness	A_V = +2, R_L = 150Ω to V+/2, R_f = 402Ω, V_{OUT} = 200mV_{PP}		15		MHz
PBW	Full Power Bandwidth	A_V = +1, −1dB, V_{OUT} = 2V_{PP}		22		MHz
e_n	Input-Referred Voltage Noise	f = 100kHz		17		nV/√Hz
		f = 1kHz		48		
i_n	Input-Referred Current Noise	f = 100kHz		0.90		pA/√Hz
		f = 1kHz		3.3		
THD	Total Harmonic Distortion	f = 5MHz, V_O = 2V_{PP}, A_V = +2		−60		dBc
DG	Differential Gain	NTSC, A_V = +2 R_L =150Ω to $V^+/2$		0.16%		
		R_L = 1kΩ to $V^+/2$		0.05%		
DP	Differential Phase	NTSC, A_V = +2 R_L = 150Ω to $V^+/2$		0.05		deg
		R_L = 1kΩ to $V^+/2$		0.01		
CT Rej.	Cross-Talk Rejection	f = 5MHz, Receiver: R_f = R_g = 510Ω, A_V = +2		47		dB
T_S	Settling Time	V_O = 2V_{PP}, ±0.1%, 8pF Load		68		ns
SR	Slew Rate [3]	A_V = −1, V_I = 2V_{PP}	95	125		V/µs
V_{OS}	Input Offset Voltage	For LMH6642		±1	±5 **±7**	mV
		For LMH6643		±1	±3.4 **±7**	
TC V_{OS}	Input Offset Average Drift	[4]		±5		µV/°C
I_B	Input Bias Current	[5]		−1.70	−2.60 **−3.25**	µA
I_{OS}	Input Offset Current			20	800 **1000**	nA
R_{IN}	Common Mode Input Resistance			3		MΩ
C_{IN}	Common Mode Input Capacitance			2		pF
CMVR	Input Common-Mode Voltage Range	CMRR ≥ 50dB		−0.5	−0.2 **−0.1**	V
			3.8 **3.6**	4.0		
CMRR	Common Mode Rejection Ratio	V_{CM} Stepped from 0V to 3.5V	72	95		dB
A_{VOL}	Large Signal Voltage Gain	V_O = 0.5V to 4.50V R_L = 2kΩ to $V^+/2$	86 **82**	98		dB
		V_O = 0.5V to 4.25V R_L = 150Ω to $V^+/2$	76 **72**	82		
V_O	Output Swing High	R_L = 2kΩ to $V^+/2$, V_{ID} = 200mV	4.90	4.98		V
		R_L = 150Ω to $V^+/2$, V_{ID} = 200mV	4.65	4.90		
	Output Swing Low	R_L = 2kΩ to $V^+/2$, V_{ID} = −200mV		25	100	mV
		R_L = 150Ω to $V^+/2$, V_{ID} = −200mV		100	150	

(1) All limits are ensured by testing or statistical analysis.
(2) Typical values represent the most likely parametric norm.
(3) Slew rate is the average of the rising and falling slew rates.
(4) Offset voltage average drift determined by dividing the change in V_{OS} at temperature extremes by the total temperature change.
(5) Positive current corresponds to current flowing into the device.

5V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for V^+ = 5V, V^- = 0V, V_{CM} = V_O = V^+/2, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to V^+/2. **Boldface** limits apply at the temperature extremes.

PARAMETER		TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
I_{SC}	Output Short Circuit Current	Sourcing to V^+/2 V_{ID} = 200mV [6]	55 **40**	115		mA
		Sinking to V^+/2 V_{ID} = −200mV [6]	70 **55**	140		
I_{OUT}	Output Current	V_O = 0.5V from either supply		±70		mA
+PSRR	Positive Power Supply Rejection Ratio	V^+ = 4.0V to 6V	79	90		dB
I_S	Supply Current (per channel)	No Load		2.70	4.25 **5.00**	mA

(6)   Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5ms.

7.7 ±5V Electrical Characteristics

Unless otherwise specified, all limits ensured for V^+ = 5V, V^- = −5V, V_{CM} = V_O = 0V, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to ground. **Boldface** limits apply at the temperature extremes.

PARAMETER		TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
BW	−3dB BW	A_V = +1, V_{OUT} = 200mV_{PP}	95	130		MHz
		A_V = +2, −1, V_{OUT} = 200mV_{PP}		46		
$BW_{0.1dB}$	0.1dB Gain Flatness	A_V = +2, R_L = 150Ω to V+/2, R_f = 806Ω, V_{OUT} = 200mV_{PP}		12		MHz
PBW	Full Power Bandwidth	A_V = +1, −1dB, V_{OUT} = 2V_{PP}		24		MHz
e_n	Input-Referred Voltage Noise	f = 100kHz		17		nV/√Hz
		f = 1kHz		48		
i_n	Input-Referred Current Noise	f = 100kHz		0.90		pA/√Hz
		f = 1kHz		3.3		
THD	Total Harmonic Distortion	f = 5MHz, V_O = 2V_{PP}, A_V = +2		−62		dBc
DG	Differential Gain	NTSC, A_V = +2 R_L = 150Ω to V^+/2		0.15%		
		R_L = 1kΩ to V^+/2		0.01%		
DP	Differential Phase	NTSC, A_V = +2 R_L = 150Ω to V^+/2		0.04		deg
		R_L = 1kΩ to V^+/2		0.01		
CT Rej.	Cross-Talk Rejection	f = 5MHz, Receiver: R_f = R_g = 510Ω, A_V = +2		47		dB
T_S	Settling Time	V_O = 2V_{PP}, ±0.1%, 8pF Load, V_S = 5V		68		ns
SR	Slew Rate [3]	A_V = −1, V_I = 2V_{PP}	100	135		V/µs
V_{OS}	Input Offset Voltage	For LMH6642		±1	±5 **±7**	mV
		For LMH6643		±1	±3.4 **±7**	
TC V_{OS}	Input Offset Average Drift	[4]		±5		µV/°C
I_B	Input Bias Current	[5]		−1.60	−2.60 **−3.25**	µA
I_{OS}	Input Offset Current			20	800 **1000**	nA
R_{IN}	Common Mode Input Resistance			3		MΩ
C_{IN}	Common Mode Input Capacitance			2		pF
CMVR	Input Common-Mode Voltage Range	CMRR ≥ 50dB		−5.5	−5.2 **−5.1**	V
			3.8 **3.6**	4.0		
CMRR	Common Mode Rejection Ratio	V_{CM} Stepped from −5V to 3.5V	74	95		dB
A_{VOL}	Large Signal Voltage Gain	V_O = −4.5V to 4.5V, R_L = 2kΩ	88 **84**	96		dB
		V_O = −4.0V to 4.0V, R_L = 150Ω	78 **74**	82		
V_O	Output Swing High	R_L = 2kΩ, V_{ID} = 200mV	4.90	4.96		V
		R_L = 150Ω, V_{ID} = 200mV	4.65	4.80		
	Output Swing Low	R_L = 2kΩ, V_{ID} = −200mV		−4.96	−4.90	V
		R_L = 150Ω, V_{ID} = −200mV		−4.80	−4.65	

(1) All limits are ensured by testing or statistical analysis.
(2) Typical values represent the most likely parametric norm.
(3) Slew rate is the average of the rising and falling slew rates.
(4) Offset voltage average drift determined by dividing the change in V_{OS} at temperature extremes by the total temperature change.
(5) Positive current corresponds to current flowing into the device.

±5V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for V^+ = 5V, V^- = −5V, V_{CM} = V_O = 0V, V_{ID} (input differential voltage) as noted (where applicable) and R_L = 2kΩ to ground. **Boldface** limits apply at the temperature extremes.

PARAMETER		TEST CONDITIONS	MIN[1]	TYP[2]	MAX[1]	UNIT
I_{SC}	Output Short Circuit Current	Sourcing to Ground V_{ID} = 200mV [6]	60 **35**	115		mA
		Sinking to Ground V_{ID} = −200mV [6]	85 **65**	145		
I_{OUT}	Output Current	V_O = 0.5V from either supply	±75			mA
PSRR	Power Supply Rejection Ratio	(V^+, V^-) = (4.5V, −4.5V) to (5.5V, −5.5V)	78	90		dB
I_S	Supply Current (per channel)	No Load		2.70	4.50 **5.50**	mA

(6) Short circuit test is a momentary test. Output short circuit duration is infinite for V_S < 6V at room temperature and below. For V_S > 6V, allowable short circuit duration is 1.5ms.

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

7.8 Typical Performance Characteristics

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
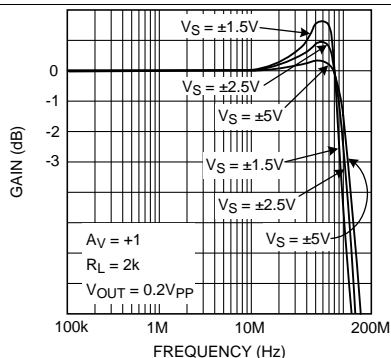
**Figure 1. Closed Loop Frequency Response
for Various Supplies**
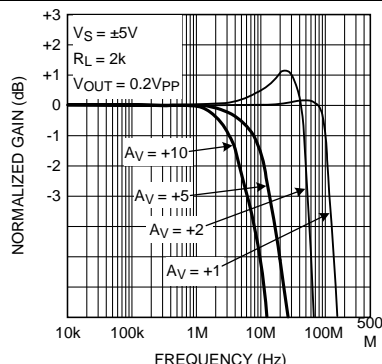
**Figure 2. Closed Loop Gain vs. Frequency
for Various Gain**
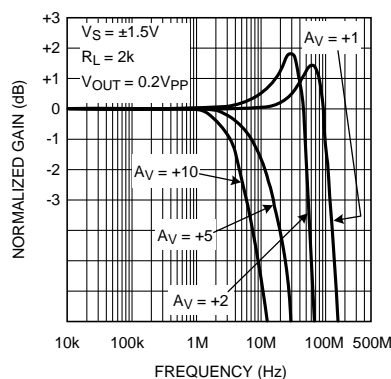
**Figure 3. Closed Loop Gain vs. Frequency
for Various Gain**
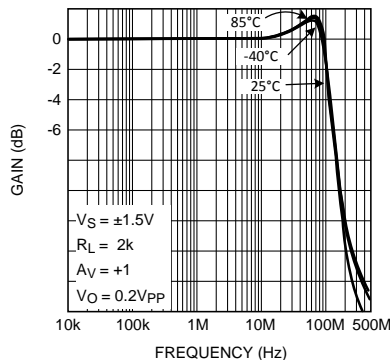
**Figure 4. Closed Loop Frequency Response
for Various Temperature**
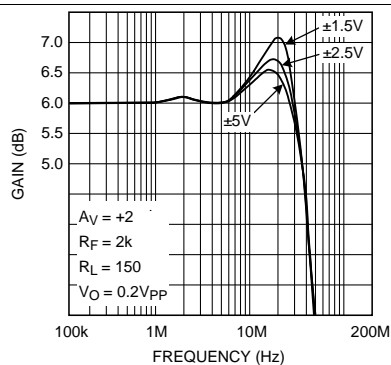
**Figure 5. Closed Loop Gain vs. Frequency
for Various Supplies**
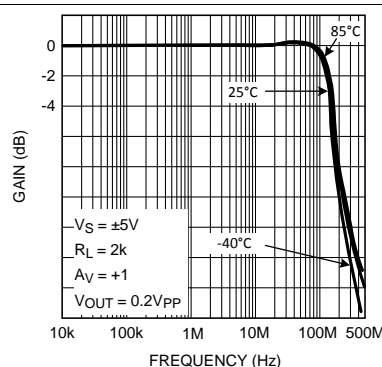
**Figure 6. Closed Loop Frequency Response
for Various Temperature**

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
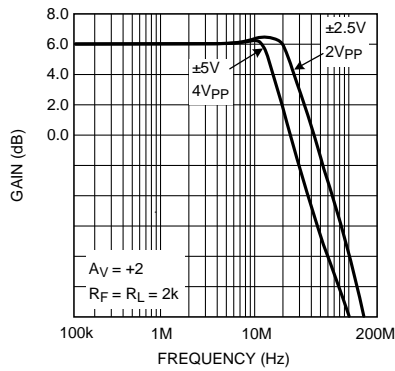
Figure 7. Large Signal Frequency Response
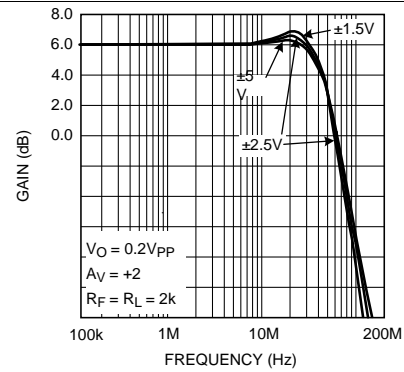
**Figure 8. Closed Loop Small Signal Frequency Response
for Various Supplies**
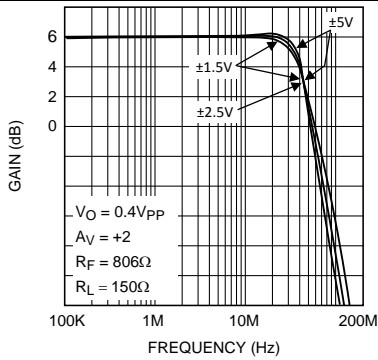
**Figure 9. Closed Loop Frequency Response
for Various Supplies**
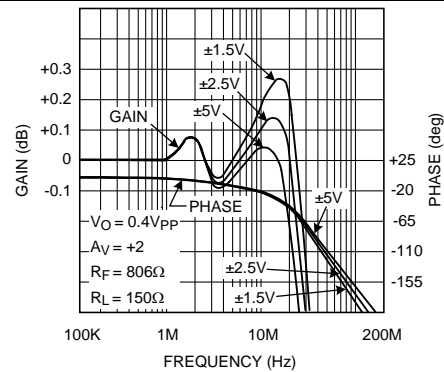
**Figure 10. ±0.1dB Gain Flatness
for Various Supplies**
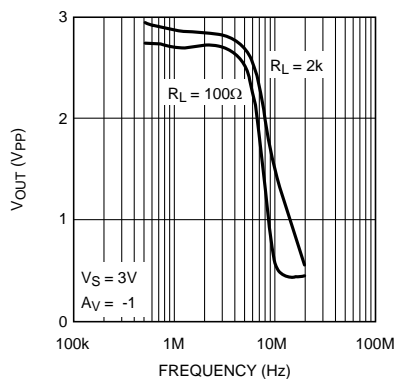
Figure 11. V_{OUT} (V_{PP}) for THD < 0.5%
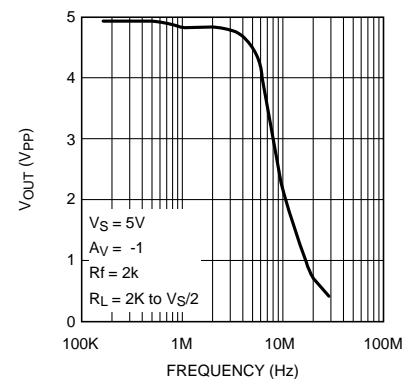
Figure 12. V_{OUT} (V_{PP}) for THD < 0.5%

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
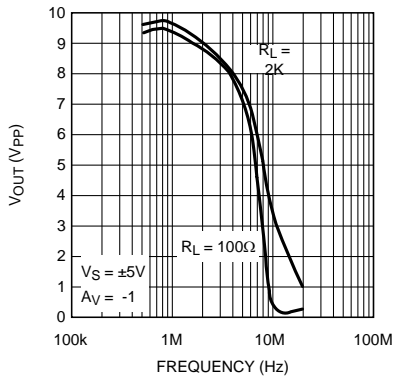
Figure 13. V_{OUT} (V_{PP}) for THD < 0.5%
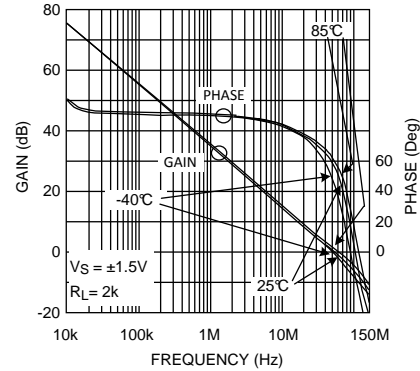
Figure 14. Open Loop Gain/Phase for Various Temperature
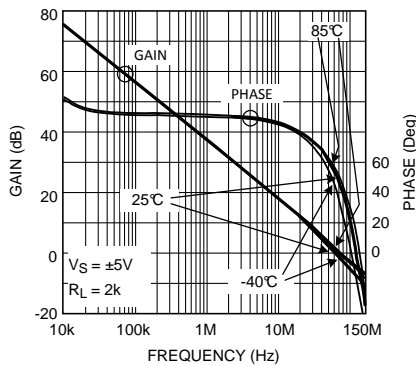
Figure 15. Open Loop Gain/Phase for Various Temperature
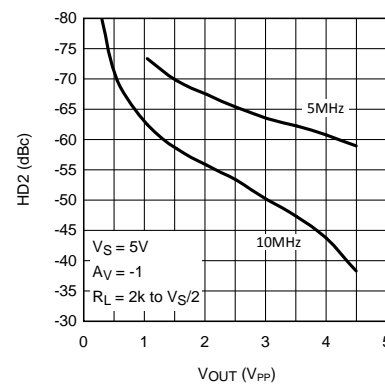
Figure 16. HD2 (dBc) vs. Output Swing
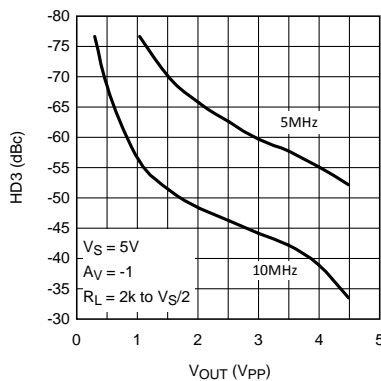
Figure 17. HD3 (dBc) vs. Output Swing
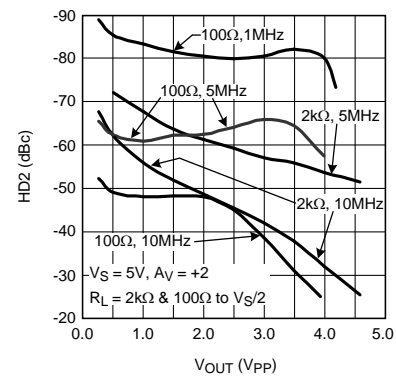
Figure 18. HD2 vs. Output Swing

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

$V^+ = +5$, $V^- = -5V$, $R_F = R_L = 2k\Omega$. Unless otherwise specified.
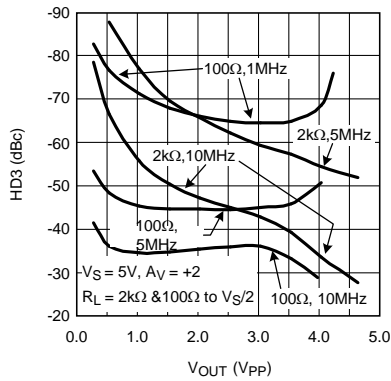
Figure 19. HD3 vs. Output Swing
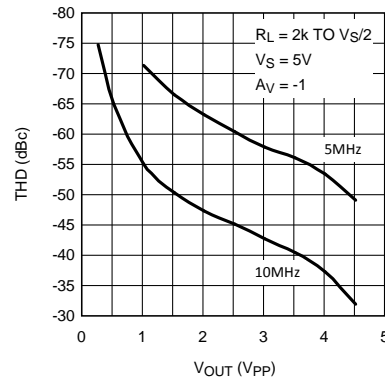
Figure 20. THD (dBc) vs. Output Swing
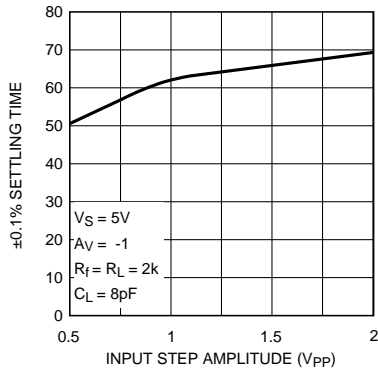
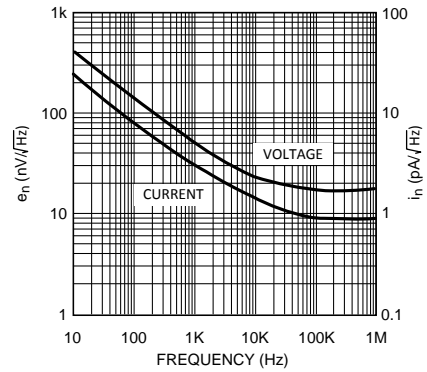**Figure 21. Settling Time vs. Input Step Amplitude
(Output Slew and Settle Time)**
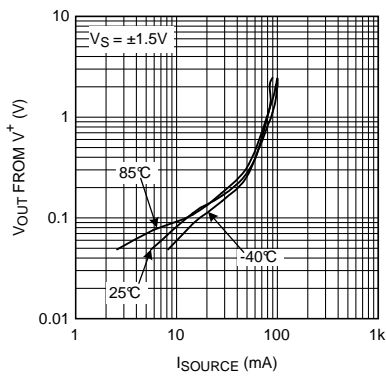

Figure 22. Input Noise vs. Frequency
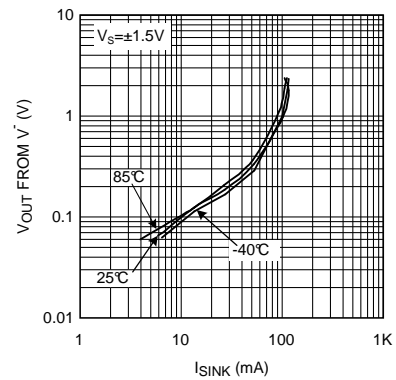

Figure 23. V$_{OUT}$ from V$^+$ vs. I$_{SOURCE}$

Figure 24. V$_{OUT}$ from V$^-$ vs. I$_{SINK}$

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

$V^+ = +5$, $V^- = -5V$, $R_F = R_L = 2k\Omega$. Unless otherwise specified.

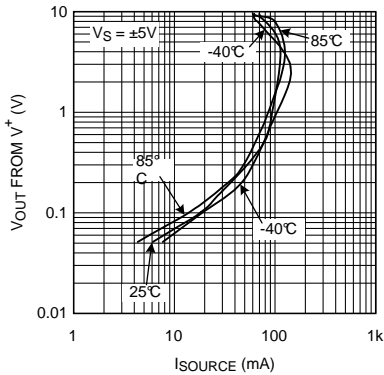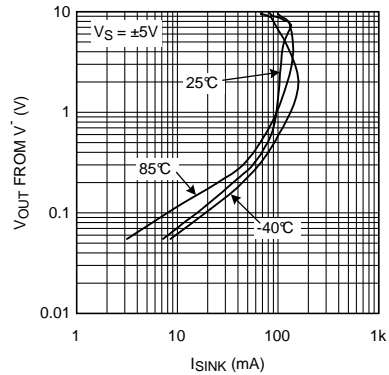**Figure 25. V_{OUT} from V^+ vs. I_{SOURCE}**

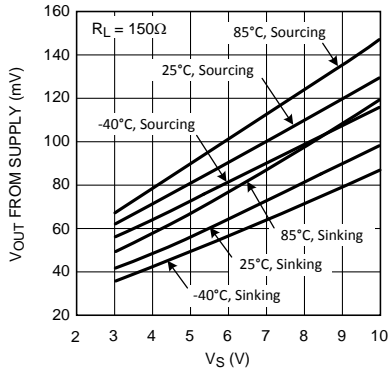**Figure 26. V_{OUT} from V^- vs. I_{SINK}**
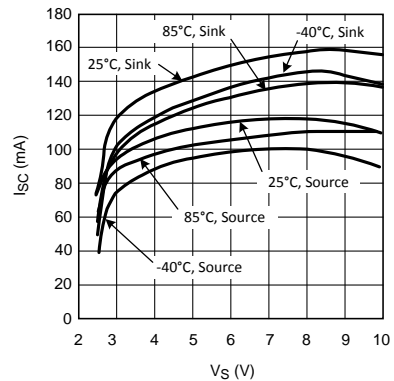

Figure 27. Swing vs. V_S

Figure 28. Short Circuit Current (to V_S/2) vs. V_S
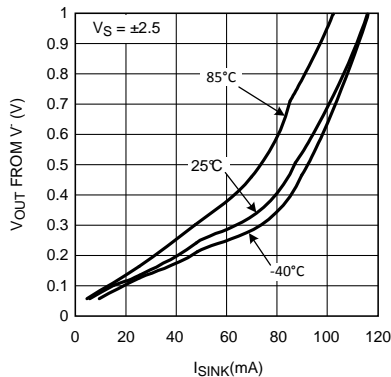

Figure 29. Output Sinking Saturation Voltage vs. I_{OUT}
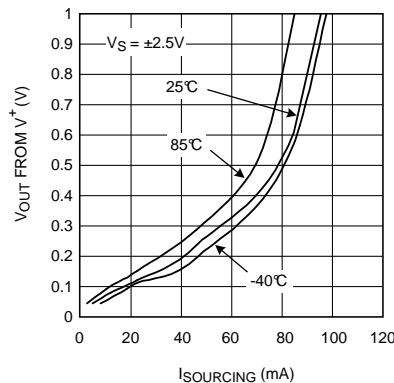

Figure 30. Output Sourcing Saturation Voltage vs. I_{OUT}

Typical Performance Characteristics (continued)

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
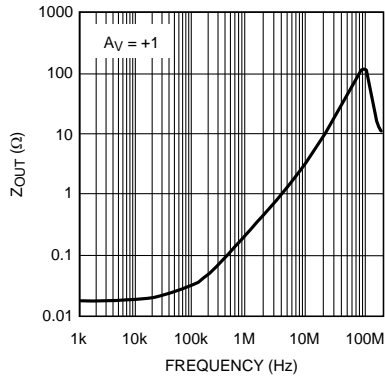

Figure 31. Closed Loop Output Impedance vs. Frequency, A_V = +1
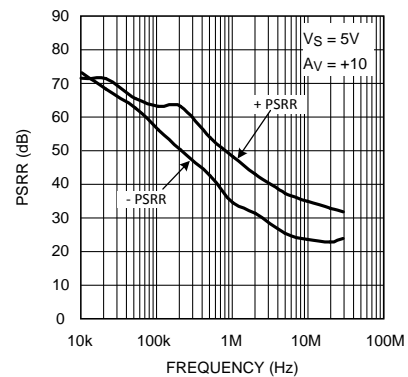

Figure 32. PSRR vs. Frequency
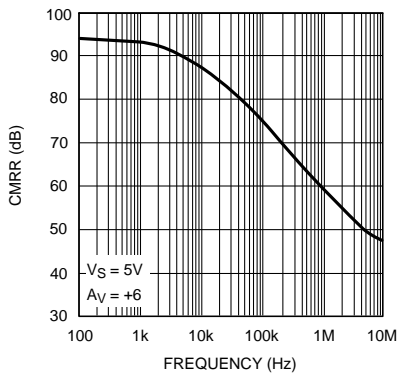
Figure 33. CMRR vs. Frequency
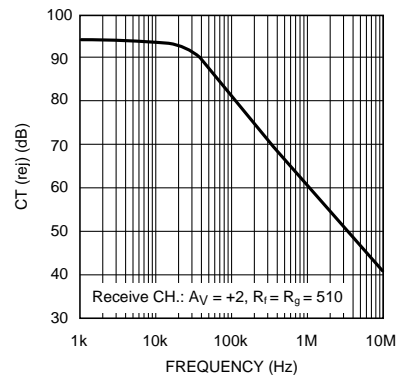
Figure 34. Crosstalk Rejection vs. Frequency (Output to Output)
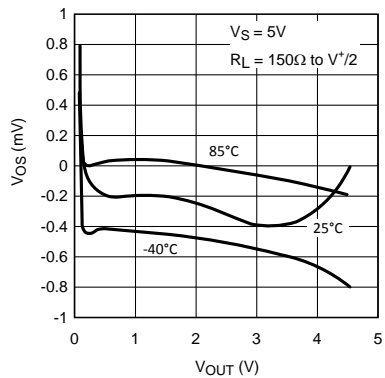
Figure 35. V_{OS} vs. V_{OUT} (Typical Unit)
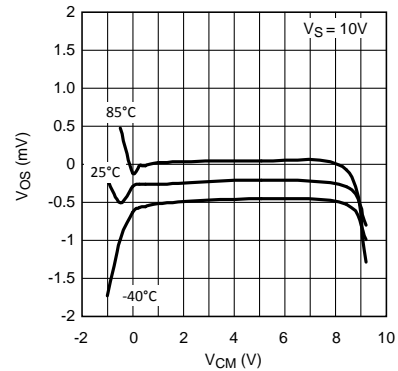
Figure 36. V_{OS} vs. V_{CM} (Typical Unit)

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

$V^+ = +5$, $V^- = -5V$, $R_F = R_L = 2k\Omega$. Unless otherwise specified.
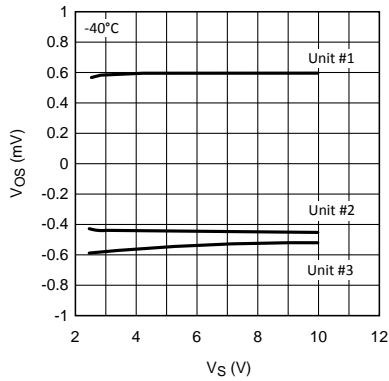
Figure 37. V_{OS} vs. V_S (for 3 Representative Units)
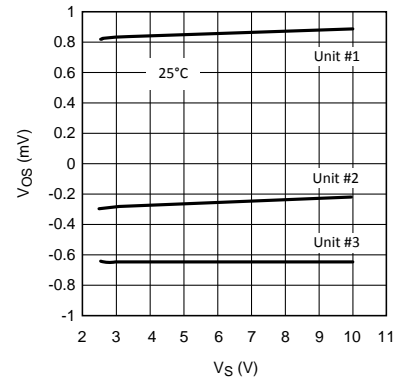
Figure 38. V_{OS} vs. V_S (for 3 Representative Units)
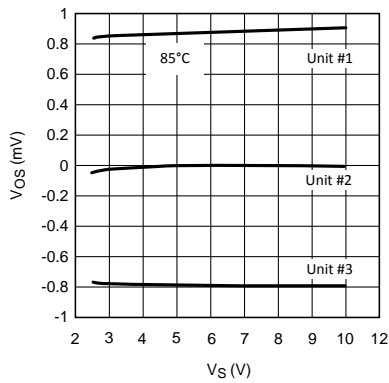
Figure 39. V_{OS} vs. V_S (for 3 Representative Units)
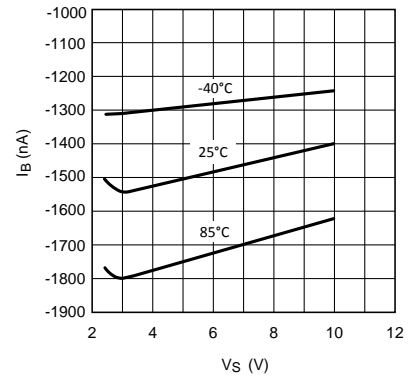
Figure 40. I_B vs. V_S
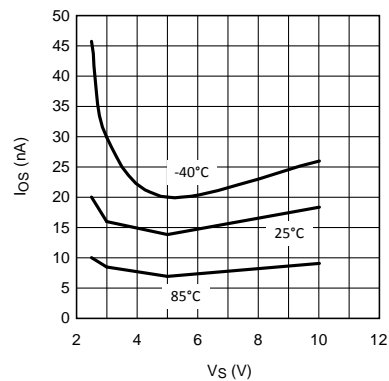
Figure 41. I_{OS} vs. V_S
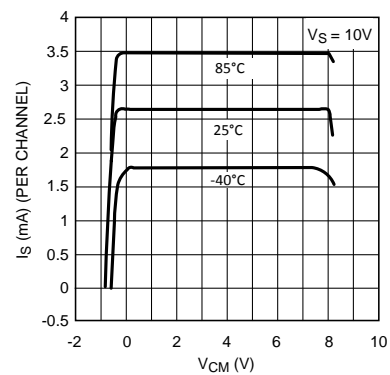
Figure 42. I_S vs. V_{CM}

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
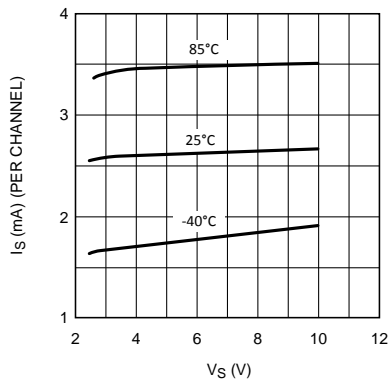
Figure 43. I_S vs. V_S
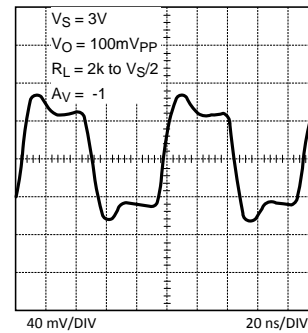
Figure 44. Small Signal Step Response
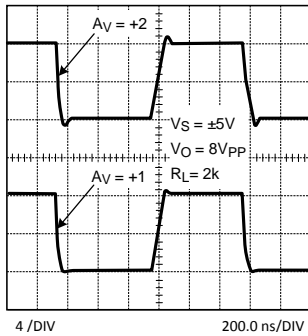
Figure 45. Large Signal Step Response
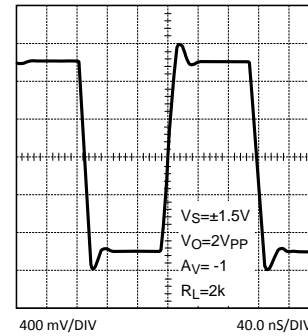
Figure 46. Large Signal Step Response
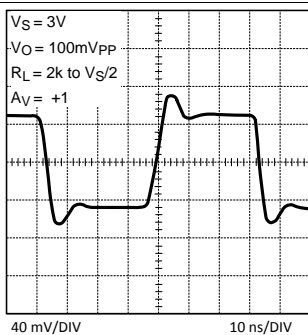
Figure 47. Small Signal Step Response
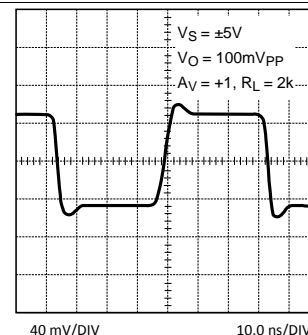
Figure 48. Small Signal Step Response

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Typical Performance Characteristics (continued)

V^+ = +5, V^- = −5V, R_F = R_L = 2kΩ. Unless otherwise specified.
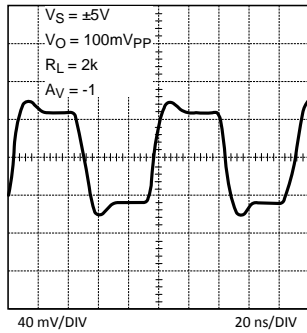
Figure 49. Small Signal Step Response
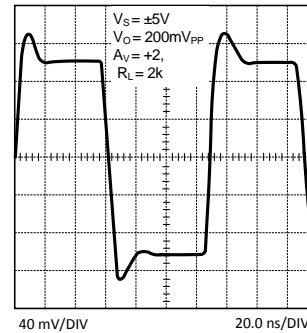
Figure 50. Small Signal Step Response
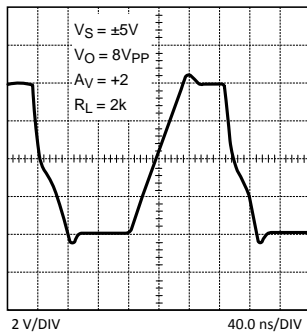
Figure 51. Large Signal Step Response
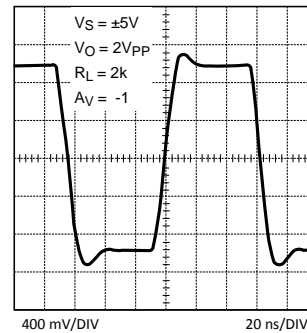
Figure 52. Large Signal Step Response
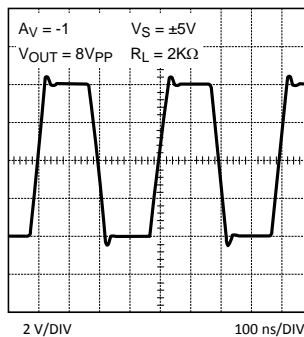
Figure 53. Large Signal Step Response

8 Application and Implementation

> **NOTE**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Circuit Description

The LMH664X family is based on Texas Instruments' proprietary VIP10 dielectrically isolated bipolar process.

This device family architecture features the following:

- Complimentary bipolar devices with exceptionally high f_t (~8 GHz) even under low supply voltage (2.7 V) and low bias current.
- A class A-B "turn-around" stage with improved noise, offset, and reduced power dissipation compared to similar speed devices (patent pending).
- Common Emitter push-push output stage capable of 75mA output current (at 0.5V from the supply rails) while consuming only 2.7 mA of total supply current per channel. This architecture allows output to reach within milli-volts of either supply rail.
- Consistent performance over the entire operating supply voltage range with little variation for the most important specifications (for example, BW, SR, I_{OUT}, and so forth).
- Significant power saving (~40%) compared to competitive devices on the market with similar performance.

8.1.1 Application Hints

This Op Amp family is a drop-in replacement for the AD805X family of high speed Op Amps in most applications. In addition, the LMH664X will typically save about 40% on power dissipation, due to lower supply current, when compared to competition. All AD805X family's ensured parameters are included in the list of LMH664X ensured specifications in order to ensure equal or better level of performance. However, as in most high performance parts, due to subtleties of applications, it is strongly recommended that the performance of the part to be evaluated is tested under actual operating conditions to ensure full compliance to all specifications.

With 3V supplies and a common mode input voltage range that extends 0.5V below V⁻, the LMH664X find applications in low voltage/low power applications. Even with 3V supplies, the −3dB BW (@ A_V = +1) is typically 115MHz with a tested limit of 80MHz. Production testing ensures that process variations with not compromise speed. High frequency response is exceptionally stable confining the typical −3dB BW over the industrial temperature range to ±2.5%.

As can be seen from the *Typical Performance Characteristics*, the LMH664X output current capability (~75mA) is enhanced compared to AD805X. This enhancement, increases the output load range, adding to the LMH664X's versatility.

Because of the LMH664X's high output current capability attention should be given to device junction temperature in order not to exceed the Absolute Maximum Rating.

Circuit Description (continued)

This device family was designed to avoid output phase reversal. With input overdrive, the output is kept near supply rail (or as closed to it as mandated by the closed loop gain setting and the input voltage). See Figure 54:
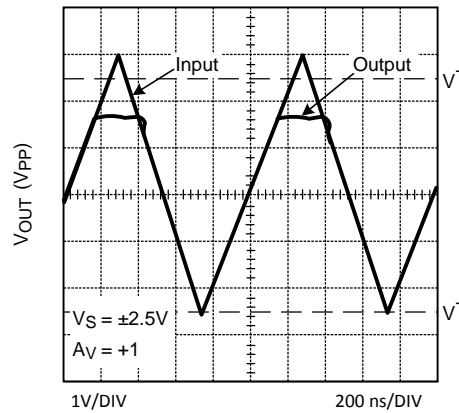
Figure 54. Input and Output Shown with CMVR Exceeded

However, if the input voltage range of −0.5V to 1V from V$^+$ is exceeded by more than a diode drop, the internal ESD protection diodes will start to conduct. The current in the diodes should be kept at or below 10mA.

Output overdrive recovery time is less than 100ns as can be seen from Figure 55 plot:
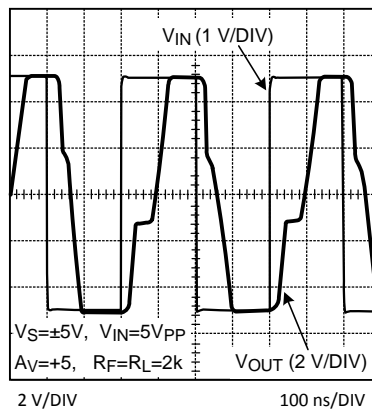
Figure 55. Overload Recovery Waveform

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

Circuit Description (continued)

8.1.2 Input and Output Topology

All input / output pins are protected against excessive voltages by ESD diodes connected to V^+ and V^- rails (see Figure 56). These diodes start conducting when the input / output pin voltage approaches $1V_{be}$ beyond V^+ or V^- to protect against over voltage. These diodes are normally reverse biased. Further protection of the inputs is provided by the two resistors (R in Figure 56), in conjunction with the string of anti-parallel diodes connected between both bases of the input stage. The combination of these resistors and diodes reduces excessive differential input voltages approaching $2V_{be}$. The most common situation when this occurs is when the device is used as a comparator (or with little or no feedback) and the device inputs no longer follow each other. In such a case, the diodes may conduct. As a consequence, input current increases and the differential input voltage is clamped. It is important to make sure that the subsequent current flow through the device input pins does not violate the Absolute Maximum Ratings of the device. To limit the current through this protection circuit, extra series resistors can be placed. Together with the built-in series resistors of several hundred ohms, these external resistors can limit the input current to a safe number (i.e. < 10mA). Be aware that these input series resistors may impact the switching speed of the device and could slow down the device.
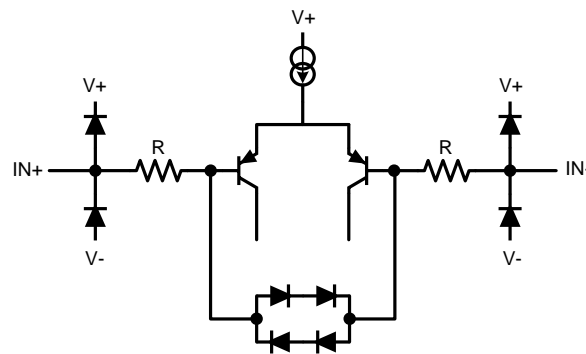
Figure 56. Input Equivalent Circuit

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

8.2 Single Supply, Low Power Photodiode Amplifier

The circuit shown in Figure 57 is used to amplify the current from a photo-diode into a voltage output. In this circuit, the emphasis is on achieving high bandwidth and the transimpedance gain setting is kept relatively low. Because of its high slew rate limit and high speed, the LMH664X family lends itself well to such an application.

This circuit achieves approximately 1V/mA of transimpedance gain and capable of handling up to 1mA$_{pp}$ from the photodiode. Q1, in a common base configuration, isolates the high capacitance of the photodiode (C_d) from the Op Amp input in order to maximize speed. Input is AC coupled through C1 to ease biasing and allow single supply operation. With 5V single supply, the device input/output is shifted to near half supply using a voltage divider from V_{CC}. Note that Q1 collector does not have any voltage swing and the Miller effect is minimized. D1, tied to Q1 base, is for temperature compensation of Q1's bias point. Q1 collector current was set to be large enough to handle the peak-to-peak photodiode excitation and not too large to shift the U1 output too far from mid-supply.

No matter how low an R_f is selected, there is a need for C_f in order to stabilize the circuit. The reason for this is that the Op Amp input capacitance and Q1 equivalent collector capacitance together (C_{IN}) will cause additional phase shift to the signal fed back to the inverting node. C_f will function as a zero in the feedback path counter-acting the effect of the C_{IN} and acting to stabilized the circuit. By proper selection of C_f such that the Op Amp open loop gain is equal to the inverse of the feedback factor at that frequency, the response is optimized with a theoretical 45° phase margin.

$$C_F = \sim \text{SQRT}\left[(C_{IN})/(2\pi \cdot \text{GBWP} \cdot R_F)\right]$$

where GBWP is the Gain Bandwidth Product of the Op Amp   (1)

Optimized as such, the I-V converter will have a theoretical pole, f_p, at:

$$f_P = \text{SQRT}\left[\text{GBWP}/(2\pi R_F \cdot C_{IN})\right]$$
(2)

With Op Amp input capacitance of 3pF and an estimate for Q1 output capacitance of about 3pF as well, C_{IN} = 6pF. From *Typical Performance Characteristics*, LMH6642/6643 family GBWP is approximately 57 MHz. Therefore, with R_f = 1k, from Equation 1 and Equation 2 above.

C_f = ~4.1 pF, and f_p = 39 MHz
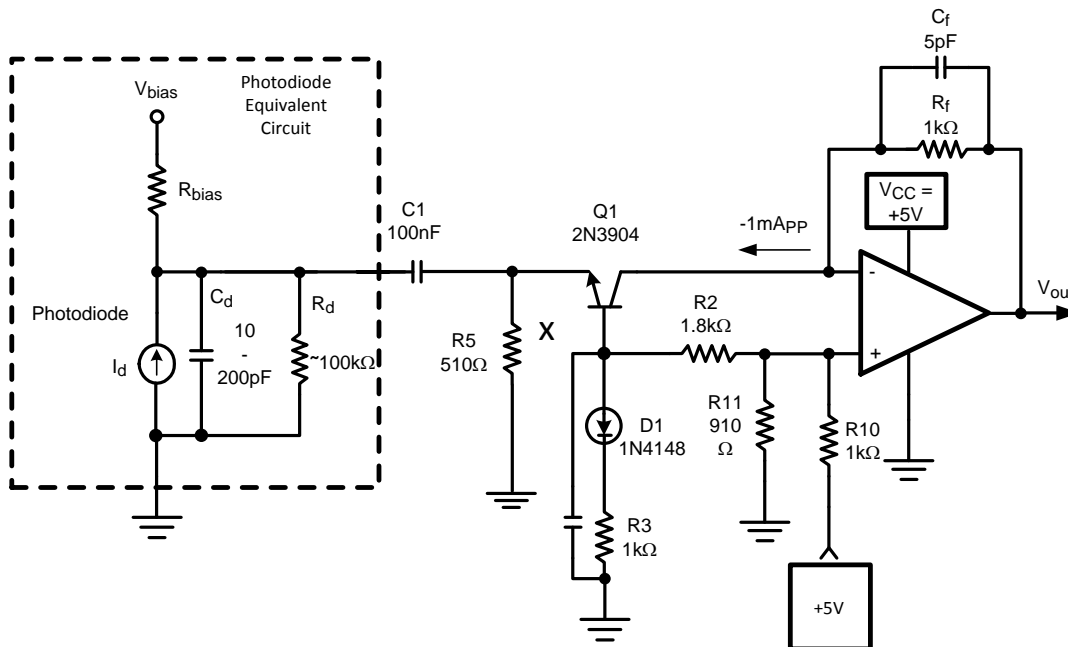
Figure 57. Single Supply Photodiode I-V Converter

Single Supply, Low Power Photodiode Amplifier (continued)

For this example, optimum C_f was empirically determined to be around 5pF. This time domain response is shown in Figure 58 below showing about 9 ns rise/fall times, corresponding to about 39 MHz for f_p. The overall supply current from the +5 V supply is around 5 mA with no load.

200 mV/DIV   20 ns/DIV
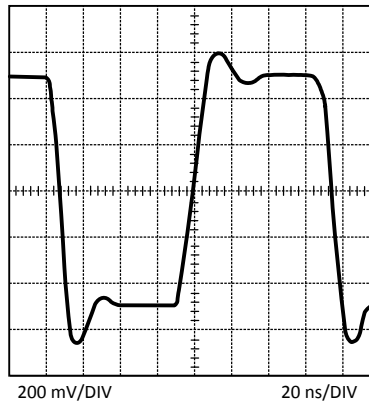
Figure 58. Converter Step Response (1V$_{PP}$, 20 ns/DIV)

8.3 Printed Circuit Board Layout and Component Values Section

Generally, a good high frequency layout will keep power supply and ground traces away from the inverting input and output pins. Parasitic capacitances on these nodes to ground will cause frequency response peaking and possible circuit oscillations (see Application Note OA-15 (SNOA367) for more information). Texas Instruments suggests the following evaluation boards as a guide for high frequency layout and as an aid in device testing and characterization:

DEVICE	PACKAGE	EVALUATION BOARD PN
LMH6642QMF	5-Pin SOT-23	LMH730216
LMH6643QMM	8-Pin VSSOP	LMH730123

Another important parameter in working with high speed/high performance amplifiers, is the component values selection. Choosing external resistors that are large in value will effect the closed loop behavior of the stage because of the interaction of these resistors with parasitic capacitances. These capacitors could be inherent to the device or a by-product of the board layout and component placement. Either way, keeping the resistor values lower, will diminish this interaction to a large extent. On the other hand, choosing very low value resistors could load down nodes and will contribute to higher overall power dissipation.

Product Folder Links: *LMH6642Q-Q1 LMH6643Q-Q1*

9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

9.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LMH6642Q-Q1	Click here	Click here	Click here	Click here	Click here
LMH6643Q-Q1	Click here	Click here	Click here	Click here	Click here

9.3 Trademarks

All trademarks are the property of their respective owners.

9.4 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

9.5 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMH6642QMF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 85	A64Q	Samples
LMH6642QMFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 85	A64Q	Samples
LMH6643QMM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 85	643Q	Samples
LMH6643QMMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 85	643Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMH6642QMF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6642QMFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6643QMM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMH6643QMMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMH6642QMF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMH6642QMFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LMH6643QMM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LMH6643QMMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0
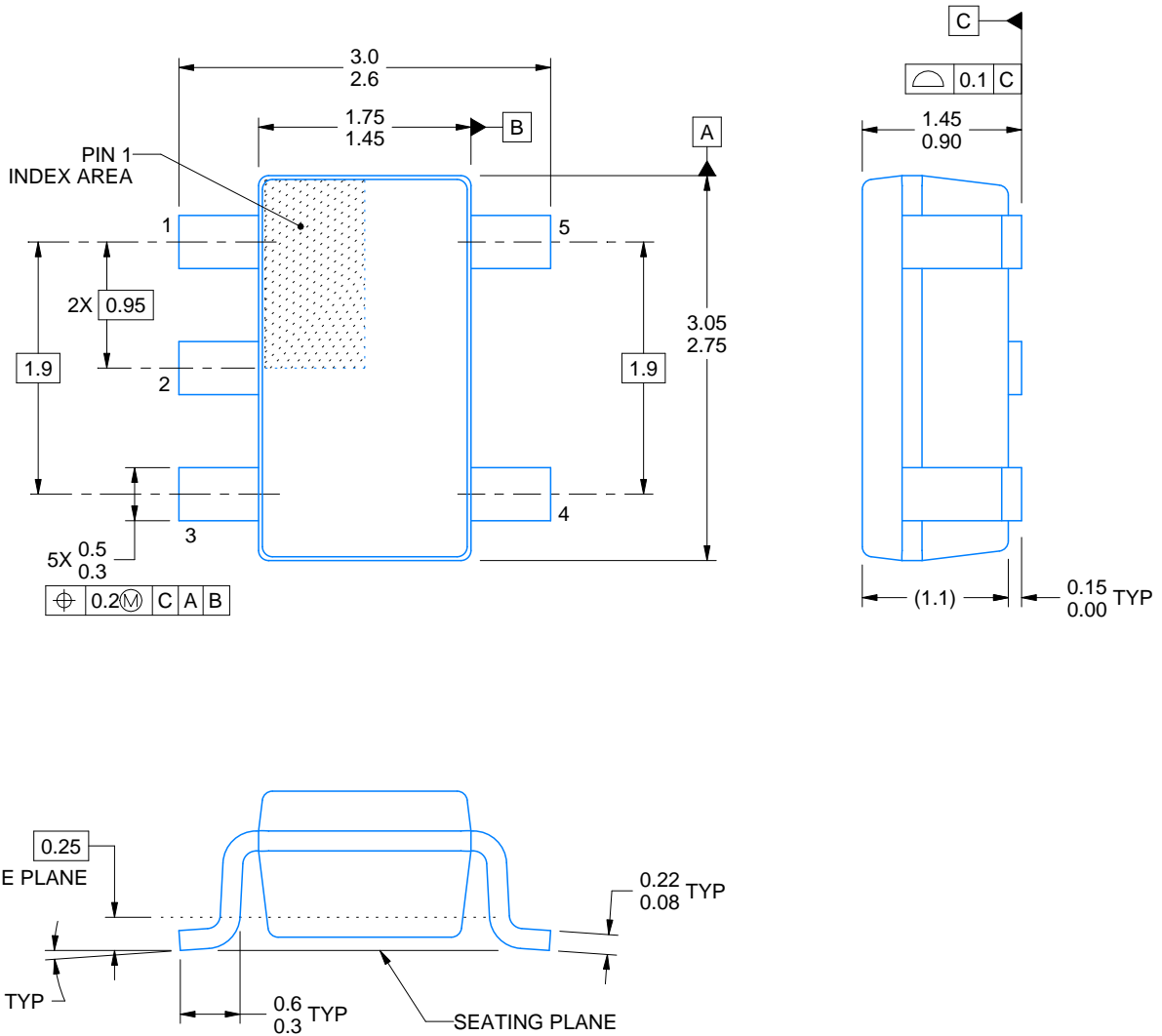
4214839/E   09/2019

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Refernce JEDEC MO-178.
4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.

PKG
℄

5X (1.1)

1

5X (0.6)

5

2

SYMM
℄

(1.9)

2X (0.95)

3

4

(R0.05) TYP

(2.6)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.07 MAX
ARROUND

NON SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.07 MIN
ARROUND

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4214839/E   09/2019

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

PKG

5X (1.1)

1

5X (0.6)

5

SYMM

2

(1.9)

2X(0.95)

3

4

(R0.05) TYP

(2.6)

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/E   09/2019

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

DGK (S−PDSO−G8)   PLASTIC SMALL−OUTLINE PACKAGE

0,65

0,38
0,25   ⊕ 0,13 Ⓜ

8   5

3,10
2,90   5,05
4,75

1   4

C
3,10
2,90

1,10 MAX   0,15
0,05

0,23
0,13

Gauge Plane

0°−8°   0,25

0,70
0,40

Seating Plane   0,10

4073329/E 05/06

NOTES: A.   All linear dimensions are in millimeters.
          B.   This drawing is subject to change without notice.
          C   Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall
                not exceed 0.15 per end.
          D   Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
          E.   Falls within JEDEC MO−187 variation AA, except interlead flash.

TEXAS
INSTRUMENTS
www.ti.com

DGK (S−PDSO−G8)   PLASTIC SMALL OUTLINE PACKAGE

Example Board Layout

Example Stencil Openings
Based on a stencil thickness
of .127mm (.005inch).
(See Note D)

(0,65)TYP.

8   5

PKG
C̵L

(4,4)

1   4

PKG
C̵L

Example
Non Soldermask Defined Pad

Example
Solder Mask Opening
(See Note E)

(0,45)

(1,45)

(0,05)
All Around

Pad Geometry
(See Note C)

8X(0,45)   (0,65)TYP.

8X(1,45)

PKG
C̵L

(4,4)

PKG
C̵L

4221236/A 11/13

NOTES: A. All linear dimensions are in millimeters.
         B. This drawing is subject to change without notice.
         C. Publication IPC−7351 is recommended for alternate designs.
         D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should
             contact their board assembly site for stencil design recommendations. Refer to IPC−7525 for other stencil recommendations.
         E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

**TEXAS
INSTRUMENTS**
www.ti.com

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.